

**Notice of References Cited**

Application/Control No.

10/539,799

Applicant(s)/Patent Under

Reexamination

PECHSTEIN ET AL.

Examiner

Dean Kwak

Art Unit

1797

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*	B	US-6,340,894	01-2002	Farnworth et al.	324/755
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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